

# NM27LV010 1,048,576-Bit (128k x 8) Low Voltage EPROM

## **General Description**

The NM27LV010 is a high performance Low Voltage Electrically Programmable Read Only Memory. It is manufactured using Fairchild's AMG™ EPROM technology. This technology allows the part to operate at speeds as fast as 200 ns.

This Low Voltage and Low Power EPROM is designed with power sensitive hand held and portable battery products in mind. This allows for code storage of firmware for applications like notebook computers, palm top computers, cellular phones, and HDD.

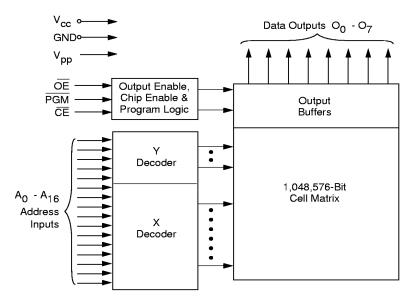
Small outline packages are just as critical to portable applications as Low Voltage and Low Power.

The NM27LV010 is one member of Fairchild's growing Low Voltage product Family.

## **Features**

- 3.0V to 3.6V operation
- 200 ns access time
- Low current operation
- -8 mA I<sub>CC</sub> active current @ 5 MHz (typ.)
- —20μA I<sub>CC</sub> standby current @ 5 MHz (typ.)
- Ultra low power operation
  - --66 μW standby power @ 3.3V
  - -50 mW active power @ 3.3V
- Surface mount package options
  - -32-pin TSOP
  - -32-pin PLCC

## **Block Diagram**



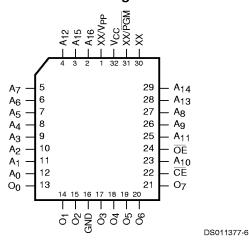
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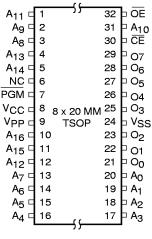
## **Connection Diagrams**

## **PLCC Pin Configuration**



**Top View** 

## **TSOP Pin Configuration**



Top View

# Commercial Temperature Range (0°C to +70°C) $V_{CC}$ = 3.3 $\pm$ 0.3

Parameter/Order Number	Access Time (ns)
NM27LV010 V, T 200	200
NM27LV010 V, T 250	250

## **Pin Names**

A0-A16	Addresses
CE	Chip Enable
ŌĒ	Output Enable
00–07	Outputs
PGM	Program
XX	Don't Care (During Read)
V <sub>PP</sub>	Programming Voltage

# Industrial Temperature Range (-40°C to +85°C) $V_{CC}$ = 3.3 $\pm\,0.3$

Parameter/Order Number	Access Time (ns)
NM27LV010 VE, TE	200
NM27LV010 VE, TE	250

Package Types: NM27LV010 V, T

V = PLCC

T = TSOP

- · All packages conform to the JEDEC standard.
- All versions are guaranteed to function for slower speeds.
- Consult the Fairchild Sales office on new released products and packages.
- Consult the Fairchild representative for custom products for your specific application.

# **Absolute Maximum Ratings** (Note 1)

All Output Voltages with Respect to Ground (Note 10) V<sub>CC</sub> + 1.0V to GND - 0.6V

Storage Temperature -65°C to +150°C

All Input Voltages except A9 with Respect to Ground (Note 10)

-0.6V to +7V

V<sub>PP</sub> and A9 with Respect to Ground

-0.6V to +14V

V<sub>CC</sub> Supply Voltage with

Respect to Ground -0.6V to +7V

ESD Protection >2000V

## **Operating Range**

Range	Temperature	V <sub>cc</sub>	Tolerance
Commercial	0°C to +70°C	3.3V	±0.3V
Industrial	-40°C to +85°C	3.3V	±0.3V

# **DC Electrical Characteristics** Over Operating Range with $V_{PP} = V_{CC}$

Symbol	Parameter	<b>Test Conditions</b>	Min	Max	Units
V <sub>IL</sub>	Input Low Level		-0.3	0.7	V
V <sub>IH</sub>	Input High Level		2.0	V <sub>CC</sub> + 0.3	V
V <sub>OL1</sub>	Output Low Voltage (TTL)	I <sub>OL</sub> = 2.0 mA		0.4	V
V <sub>OH1</sub>	Output High Voltage (TTL)	I <sub>OH</sub> = -2.0 mA	2.4		V
V <sub>OL2</sub>	Output Low Voltage	I <sub>OL</sub> = 100 μA		0.2	V
V <sub>OH2</sub>	Output High Voltage (CMOS)	I <sub>OH</sub> = -100 μA	V <sub>CC</sub> - 0.3		
I <sub>SB1</sub>	V <sub>CC</sub> Standby Current (CMOS)	$\overline{\text{CE}} = V_{\text{CC}} \pm 0.3V$		50	μА
I <sub>SB2</sub>	V <sub>CC</sub> Standby Current (TTL)	CE = V <sub>IH</sub>		100	μΑ
I <sub>cc</sub>	V <sub>CC</sub> Active Current	$\overline{CE} = \overline{OE} = V_{ L},$ $f = 5 \text{ MHz}$ $I/O = 0  \mu\text{A}$		15	mA
I <sub>PP</sub>	V <sub>PP</sub> Supply Current	$V_{PP} = V_{CC}$		10	μА
V <sub>PP</sub>	V <sub>PP</sub> Read Voltage		V <sub>CC</sub> - 0.7	V <sub>cc</sub>	V
I <sub>LI</sub>	Input Load Current	V <sub>IN</sub> = 3.0V or GND		1	μА
I <sub>LO</sub>	Output Leakage Current	V <sub>OUT</sub> = 3.0V or GND	-1	10	μΑ

# AC Electrical Characteristics Over Operating Range with $V_{PP} = V_{CC}$

· · ·							
Symbol	Parameter	2	00	25	Units		
,		Min	Max	Min	Max		
t <sub>ACC</sub>	Address to Output Delay		200		250	ns	
t <sub>CE</sub>	CE to Output Delay		200		250		
t <sub>OE</sub>	OE to Output Delay		70		75		
t <sub>DF</sub> (Note 2)	Output Disable to Output Float		50		50		
t <sub>OH</sub> (Note 2)	Output Hold from Addresses, CE or OE , Whichever Occurred First	0		0			

## Capacitance (Note 2) $T_A = +25$ °C, 1 = 1 MHz

Symbol	Parameter	Conditions	Тур	Max	Units
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0V	9	15	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0V	12	15	pF

## **AC Test Conditions**

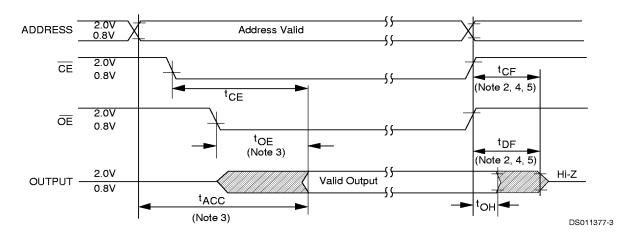
Output Load 1 TTL Gate and  $C_L = 100 pF$  (Note 8)

Input Rise and Fall Times ≤5 ns 0.45V to 2.4V Input Pulse Levels

Timing Measurement Reference Level

0.8V and 2V Inputs Outputs 0.8V and 2V

## AC Waveforms (Note 6), (Note 7), and (Note 9)



Note 1: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operations sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note 2: This parameter is only sampled and is not 100% tested.

Note 3:  $\overline{\text{OE}}$  may be delayed up to  $t_{ACC}$  -  $t_{CE}$  after the falling edge of  $\overline{\text{CE}}$  without impacting  $t_{ACC}$ .

**Note 4:** The  $t_{DF}$  and  $t_{CF}$  compare level is determined as follows: High to TRI-STATE®, the measured  $V_{OH1}$  (DC) - 0.10V; Low to TRI-STATE, the measured  $V_{OL1}$  (DC) + 0.10V.

Note 5: TRI-STATE may be attained using OE or CE

Note 6: The power switching characteristics of EPROMs require careful device decoupling. It is recommended that at least a 0.2 µF ceramic capacitor be used on every device between V<sub>CC</sub> and GND.

Note 7: The outputs must be restricted to  $V_{CC}$  + 1.0V to avoid latch-up and device damage.

Note 8: 1 TTL Gate:  $I_{OL}$  = 1.6 mA,  $I_{OH}$  = -400  $\mu$ A.

C<sub>L</sub>: 100pF includes fixture capacitance

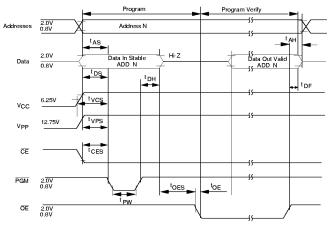
Note 9:  $V_{\rm PP}$  may be connected to  $V_{\rm CC}$  except during programming.

Note 10: Inputs and outputs can undershoot to -2.0V for 20 ns Max.

## Programming Characteristics (Note 11), (Note 12), (Note 13) and (Note 14)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
t <sub>AS</sub>	Address Setup Time		1			μs	
t <sub>OES</sub>	OE Setup Time		1			μs	
t <sub>CES</sub>	CE Setup Time		1			μs	
t <sub>DS</sub>	Data Setup Time		1			μs	
t <sub>VPS</sub>	V <sub>PP</sub> Setup Time		1			μs	
t <sub>VCS</sub>	V <sub>CC</sub> Setup Time		1			μs	
t <sub>AH</sub>	Address Hold Time		0			μs	
t <sub>DH</sub>	Data Hold Time		1			μs	
t <sub>DF</sub>	Output Enable to Output Float Delay	CE/PGM = V <sub>IL</sub>	0		60	ns	
t <sub>PW</sub>	Program Pulse Width		45	50	105	μs	
t <sub>OE</sub>	Data Valid from OE	CE/PGM = V <sub>IL</sub>			100	ns	
I <sub>PP</sub>	V <sub>PP</sub> Supply Current during Programming Pulse	CE/PGM = V <sub>IL</sub>			20	mA	
I <sub>cc</sub>	V <sub>CC</sub> Supply Current				20	mA	
T <sub>A</sub>	Temperature Ambient		20	25	30	°C	
V <sub>CC</sub>	Power Supply Voltage		6.25	6.5	6.75	V	
V <sub>PP</sub>	Programming Supply Voltage		12.5	12.75	13.0	V	
t <sub>FR</sub>	Input Rise, Fall Time		5			ns	
V <sub>IL</sub>	Input Low Voltage			0.0	0.45	V	
V <sub>IH</sub>	Input High Voltage		2.4	4.0		V	
t <sub>IN</sub>	Input Timing Reference Voltage		0.8		2.0	V	
t <sub>OUT</sub>	Output Timing Reference Voltage		0.8		2.0	V	

## **Programming Waveform** (Note 13)



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Note 11: Fairchild's standard product warranty applies to devices programmed to specifications described herein.

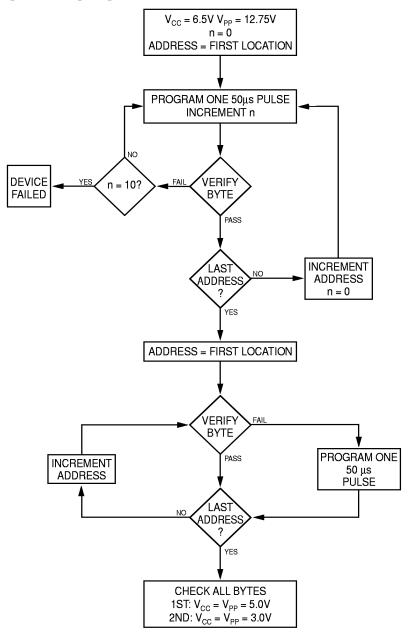
Note 12:  $V_{CC}$  must be applied simultaneously or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ . The EPROM must not be inserted into or removed from a board with voltage applied to  $V_{PP}$  or  $V_{CC}$ .

Note 13: The maximum absolute allowable voltage which may be applied to the V<sub>PP</sub> pin during programming is 14V. Care must be taken when switching the V<sub>PP</sub> supply to prevent any overshoot from exceeding this 14V maximum specification. At least a 0.1 μF capacitor is required across V<sub>PP</sub>, V<sub>CC</sub> to GND to suppress spurious voltage transients which may damage the device.

Note 14: During power up the  $\overline{\text{PGM}}$  pin must be brought high (≥ V<sub>IH</sub>) either coincident with or before power is applied to V<sub>PP</sub>.

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# LV Turbo Programming Algorithm Flow Chart



Note: The standard National Semiconductor algorithm may also be used but it will have longer programming time.

FIGURE 1.

# Functional Description DEVICE OPERATION

The six modes of operation of the EPROM are listed in Table 1. It should be noted that all inputs for the six modes are at TTL levels. The power supplies required are  $V_{CC}$  and  $V_{PP}$ . The  $V_{PP}$  power supply must be at 12.75V during the three programming modes, and must be at 3.3V in the other three modes. The  $V_{CC}$  power supply must be at 6.5V during the three programming modes, and at 3.3V in the other three modes.

#### **Read Mode**

The EPROM has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable  $(\overline{CE})$  is the power control and should be used for device selection. Output Enable  $(\overline{OE})$  is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that addresses are stable, address access time  $(t_{ACC})$  is equal to the delay from  $\overline{CE}$  to output  $(t_{CE})$ . Data is available at the outputs  $t_{OE}$  after the falling edge of  $\overline{OE}$ , assuming that  $\overline{CE}$  has been low and addresses have been stable for at least  $t_{ACC}$  – $t_{OE}$ .

#### Standby Mode

The EPROM has a standby mode which reduces the active power dissipation by over 99%, from 50 mW to 0.17 mW. The EPROM is placed in the standby mode by applying a CMOS high signal to the  $\overline{CE}$  input. When in standby mode, the outputs are in a high impedance state, independent of the  $\overline{OE}$  input.

#### **Output Disable**

The EPROM is placed in output disable by applying a TTL high signal to the  $\overline{OE}$  input. When in output disable all circuitry is enabled, except the outputs are in a high impedance state (TRI-STATE).

## **Output OR-Tying**

Because the EPROM is usually used in larger memory arrays, Fairchild has provided a 2-line control function that accommodates this use of multiple memory connections. The 2-line control function allows for:

- 1. the lowest possible memory power dissipation, and
- complete assurance that output bus contention will not occur.

To  $\underline{most}$  efficiently use these two control lines, it is recommended that  $\overline{CE}$  be decoded and used as the primary device selecting function, while  $\overline{OE}$  be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low power standby modes and that the output pins are active only when data is desired from a particular memory device.

#### **Programming**

CAUTION: Exceeding 14V on pin 1 (V<sub>PP</sub>) will damage the EPROM.

Initially, and after each erasure, all bits of the EPROM are in the "1's" state. Data is introduced by selectively programming "0's" into the desired bit locations. Although only "0's" will be programmed, both "1's" and "0's" can be presented in the data word. The only way to change a "0" to a "1" is by ultraviolet light erasure.

The EPROM is in the programming mode when the  $V_{PP}$  power supply is at 12.75V and  $\overline{OE}$  is at  $V_{IH}$ . It is required that at least a

0.1  $\mu$ F capacitor be placed across V<sub>PP</sub> and V<sub>CC</sub> to ground to suppress spurious voltage transients which may damage the device. The data to be programmed is applied 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.

When the address and data are stable, an active low, TTL program pulse is applied to the  $\overline{PGM}$  input. A program pulse must be applied at each address location to be programmed. The EPROM is programmed with the LV Turbo Programming Algorithm shown in Figure 1. Each Address is programmed with a series of 50  $\mu s$  pulses until it verifies good, up to a maximum of 10 pulses. Most memory cells will program with a single 50  $\mu s$  pulse. (The standard National Semiconductor Algorithm may also be used, but it will have longer programming time.)

The  $\stackrel{\mbox{\footnotesize EPROM}}{\mbox{\footnotesize must}}$  must not be programmed with a DC signal applied to the  $\stackrel{\mbox{\footnotesize PGM}}{\mbox{\footnotesize input}}$  input.

Programming multiple EPROM in parallel with the same data can be easily accomplished due to the simplicity of the programming requirements. Like inputs of the parallel EPROM may be connected together when they are programmed with the same data. A low level TTL pulse applied to the PGM input programs the paralleled EPROM.

## **Program Inhibit**

Programming multiple EPROM's in parallel with different data is also easily accomplished. Except for  $\overline{CE}$ , all like inputs (including  $\overline{OE}$  and  $\overline{PGM}$ ) of the parallel EPROM may be common. A TTL low level program pulse applied to an EPROM's  $\overline{PGM}$  input with  $\overline{CE}$  at  $\underline{V_{\parallel}}$  and  $\overline{V_{PP}}$  at 12.75V will program that EPROM. A TTL high level  $\overline{CE}$  input inhibits the other EPROM's from being programmed.

#### **Program Verify**

A verify should be performed on the programmed bits to determine whether they were correctly programmed. The verify may be performed with  $V_{PP}$  at 6.25V.  $V_{PP}$  must be at  $V_{CC}$ , except during programming and program verify.

## **AFTER PROGRAMMING**

Opaque labels should be placed over the EPROM window to prevent unintentional erasure. Covering the window will also prevent temporary functional failure due to the generation of photo currents.

### MANUFACTURER'S IDENTIFICATION CODE

The EPROM has a manufacturer's identification code to aid in programming. When the device is inserted in an EPROM programmer socket, the programmer reads the code and then automatically calls up the specific programming algorithm for the part. This automatic programming control is only possible with programmers which have the capability of reading the code.

The Manufacturer's Identification code, shown in Table 2, specifically identifies the manufacturer and device type. The code for the NM27LV010 is "8F86", where "8F" designates that it is made by Fairchild Semiconductor, and "86" designates a 1 Megabit (128k x 8) part.

The code is accessed by applying 12V  $\pm 0.5$ V to address pin A9. Addresses A1–A8, A10–A16, and all control pins are held at V $_{\rm IL}$ . Address pin A0 is held at V $_{\rm IL}$  for the manufacturer's code, and held at V $_{\rm IH}$  for the device code. The code is read on the lower eight data pins, O0–07. Proper code access is only guaranteed at 25°C  $\pm$ 5°C.

# Functional Description (Continued) ERASURE CHARACTERISTICS

The erasure characteristics of the device are such that erasure begins to occur when exposed to light with wavelengths shorter than approximately 4000 Angstroms (Å). It should be noted that sunlight and certain types of fluorescent lamps have wavelengths in the 3000Å – 4000Å range.

The recommended erasure procedure for the EPROM is exposure to short wave ultraviolet light which has a wavelength of 2537Å. The integrated dose (i.e., UV intensity x exposure time) for erasure should be a minimum of 30W-sec/cm<sup>2</sup>.

The EPROM should be placed within 1 inch of the lamp tubes during erasure. Some lamps have a filter on their tubes which should be removed before erasure.

An erasure system should be calibrated periodically. The distance from lamp to device should be maintained at one inch. The erasure time increases as the square of the distance from the lamp (if distance is doubled the erasure time increases by factor of 4). Lamps lose intensity as they age. When a lamp has aged, the system should be checked to make certain full erasure is occur-

ring. Incomplete erasure will cause symptoms that can be misleading. Programmers, components, and even system designs have been erroneously suspected when incomplete erasure was the problem.

#### SYSTEM CONSIDERATION

The power switching characteristics of EPROMs require careful decoupling of the devices. The supply current,  $I_{\rm CC}$ , has three segments that are of interest to the system designer: the standby current level, the active current level, and the transient current peaks that are produced by voltage transitions on input pins. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. The associated  $V_{\text{CC}}$ transient voltage peaks can be suppressed by properly selected decoupling capacitors. It is recommended that at least a 0.1  $\mu\text{F}$ ceramic capacitor be used on every device between V<sub>CC</sub> and GND. This should be a high frequency capacitor of low inherent inductance. In addition, at least a  $4.7\,\mu\text{F}$  bulk electrolytic capacitor should be used between  $V_{CC}$  and GND for each eight devices. The bulk capacitor should be located near where the power supply is connected to the array. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of the PC board traces.

### **Mode Selection**

The modes of operation of the NM27LV010 are listed in Table 1. A single 3.3V power supply is required in the read mode. All inputs are TTL levels except for V<sub>PP</sub> and A9 for device signature.

**TABLE 1. Modes Selection** 

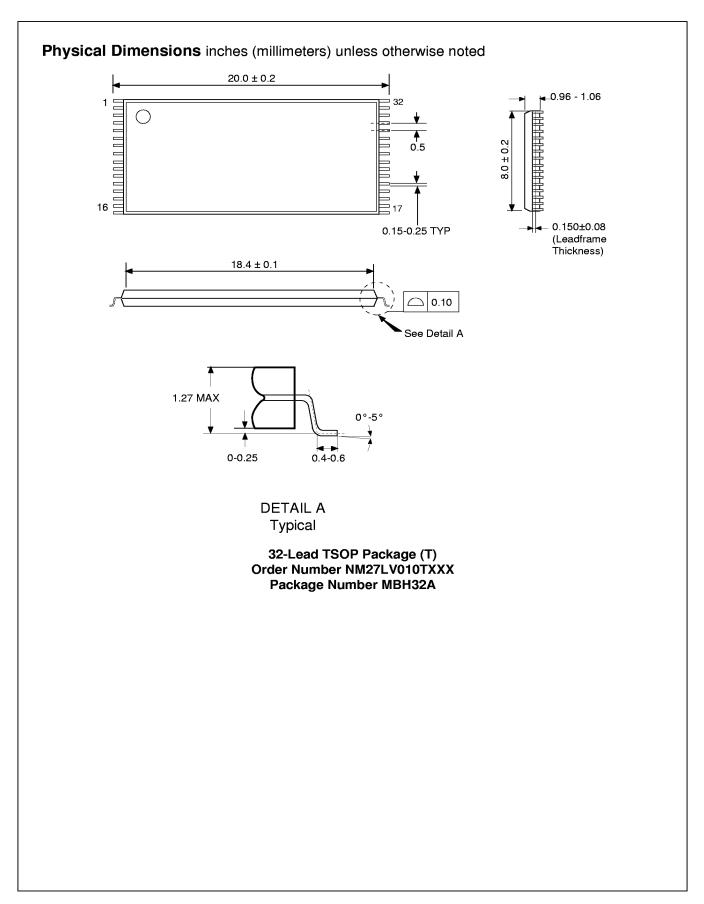
Pin	s CE	OE	PGM	V <sub>PP</sub>	V <sub>cc</sub>	Outputs
Mode						•
Read	V <sub>IL</sub>	V <sub>IL</sub>	Х	V <sub>CC</sub>	3.3V	D <sub>OUT</sub>
Output Disable	X (Note 15)	V <sub>IH</sub>	Х	V <sub>CC</sub>	3.3V	High Z
Standby	V <sub>IH</sub>	Х	Х	V <sub>CC</sub>	3.3V	High Z
Programming	V <sub>IL</sub>	V <sub>IH</sub>	V <sub>IL</sub>	12.75V	6.25V	D <sub>IN</sub>
Program Verify	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>IH</sub>	12.75V	12.75V	D <sub>OUT</sub>
Program Inhibit	V <sub>IH</sub>	V <sub>IH</sub>	Х	12.75V	6.25V	High Z

Note 15: X can be  $V_{IL}$  or  $V_{IH}$  .

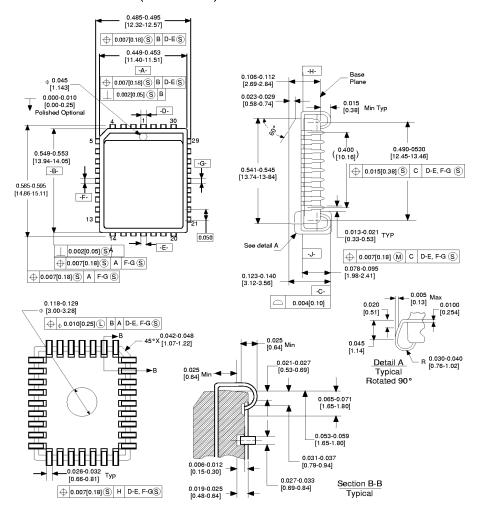
**TABLE 2. Manufacturer's Identification Code** 

Pins	A0 (12)	A9 (26)	O7 (21)	O6 (20)	O5 (19)	O4 (18)	O3 (17)	O2 (15)	O1 (14)	O0 (13)	Hex Data
Manufacturer Code	V <sub>IL</sub>	12V	1	0	0	0	1	1	1	1	8F
Device Code	V <sub>IH</sub>	12V	1	0	0	0	0	1	1	0	86

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## Physical Dimensions inches (millimeters) unless otherwise noted



32-Lead PLCC Package Order Number NM27LV010VXXX Package Number VA32A

### Life Support Policy

Fairchild's products are not authorized for use as critical components in life support devices or systems without the express written approval of the President of Fairchild Semiconductor Corporation. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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